IN THE U.S. PATENT AND TRADEMARK OFFICE

Applicant:

Youji TERAUCHI

Appl. No.:

NEW NON-PROVISIONAL

Group:

Filed:

January 29, 2004

Examiner:

For:

SEMICONDUCTOR DEVICE AND TESTING CIRCUIT WHICH CAN CARRIES OUT A VERIFYING TEST EFFECTIVELY FOR NON VOLATILE MEMORY CELLS

INFORMATION DISCLOSURE STATEMENT
(SUBMISSION CONCURRENT WITH THE
FILING OF A NEW PATENT APPLICATION)

Assistant Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

January 29, 2004

Sir:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98, and in fulfillment of the duty of disclosure under 37 C.F.R. § 1.56, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

I. LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

II. COPIES

	Copies	of	the U	.s.	patents	or	pub	lications	are	not	submitted
_	since	the	USPTO	has	waived	the	eir	submission	ı foı	c app	plications
	filed	afte	r June	30,	2003.						

- Submitted herewith is a legible copy of (i) each foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should have been forwarded from the International Search Authority pursuant to the trilateral agreement between the USPTO, EPO and JPO, or they are U.S. patents or U.S. published applications. If copies are needed, please contact the undersigned.



III. CONCISE EXPLANATION OF THE RELEVANCE

(cnec	k at	least o	ne box)						
a.		DOCUMEN	TS IN THE ENGLISH LANGUAGE						
		informa	ttached patents, publications, or other tion in the English language do not require a nt of relevancy.						
b.	\boxtimes	DOCUMENTS NOT IN THE ENGLISH LANGUAGE							
		patents	ise explanation of the relevance of all , publications, or other information listed not in the English language is as follows:						
		Abstrac	t provided for the examiner's convenience						
c.		FOREIGN SEARCH REPORT OR ACTION							
		action by the satisfy	ish language version of the search report or that indicates the degree of relevance found for effice is attached, thereby ing the requirement for a concise tion. See MPEP 609(A)(3).						
d.									
The following additional information is provided for the Examiner's consideration.									
			FEES						
This concurrent therefore,	ly	with t	n Disclosure Statement is being filed he filing of a new patent application;						
If Th	ed Ex	aminer l	nas any questions concerning this IDS, he/she t the undersigned.						
			Respectfully submitted,						
			YOUNG & THOMPSON						
			Benoît Castel Benoît Castel, Reg. No. 35,041						
BC/yr			745 South 23 rd Street Arlington, VA 22202 Telephone (703) 521-2297						
Enclosures	:		rm PTO-1449(s)						
		□ Do	cuments						
		☐ Fo	reign Search Report						
		Ot	her:						

INFO	RMATION DISCLOSU	RE CITATION	Attorney Docket No.: 8022-1066		Application No.: NEW NONPROVISIONAL				
	IN AN APPLICAT	ION	Applicant: Youji TERAUCHI						
	(Use several sheets if nec	essary)	Filing Date: January 29, 2004		Group Art Unit:				
		U.S. PATEN	T DOCUMENTS						
Examine: Initial	Document Number	Date	Name	Class	Subclass	Filing date (if appropriate)			
<u> </u>									
: -						· · · · · · · · · · · · · · · · · · ·			
				-					
		FOREIGN PAT	ENT DOCUMENTS			• • •			
Examiner Initial	Document Number	Date	Date Country		S Subclass	Yes No			
	2001-155500	6/8/2001	JAPAN			*			
				100		nin — is			
	-								
	OTHER DOCUM	ENTS (Including A	uthor, Title, Date, Pertine	nt Pages,	Etc.)				
			-						
EXAMIN	IER:		DATE CONSIDERED						
EXAMINI not in cor	ER: Initial if citation considered and not considered.	d, whether or not citation	on is in conformance with MPE orm with next communication t	P § 609. It to the appli	Draw line thro	ugh citat	ion if		

* Abstract provided for the Examiner's convenience